

MOS FIELD EFFECT TRANSISTOR NP88N055CLE, NP88N055DLE, NP88N055ELE

SWITCHING N-CHANNEL POWER MOS FET **INDUSTRIAL USE**

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance

 $R_{DS(on)1} = 5.2 \text{ m}\Omega$ MAX. (Vgs = 10 V, ID = 44 A)

 $R_{DS(on)2} = 6.3 \text{ m}\Omega$ MAX. (Vgs = 5.0 V, ID = 44 A)

- Low Ciss: Ciss = 9700 pF TYP.
- Built-in gate protection diode

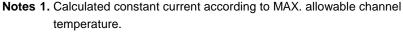
ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|----------|
| NP88N055CLE | TO-220AB |
| NP88N055DLE | TO-262 |
| NP88N055ELE | TO-263 |

(TO-220AB)



| Drain to Source Voltage | Voss | 55 | V |
|-------------------------------------------------|-----------------------|-------------|----|
| Gate to Source Voltage | Vgss | ±20 | V |
| Drain Current (DC) Note1 | I _{D(DC)} | ±88 | Α |
| Drain Current (Pulse) Note2 | I _{D(pulse)} | ±352 | Α |
| Total Power Dissipation (T _A = 25°C) | Рт | 1.8 | W |
| Total Power Dissipation (Tc = 25°C) | Рт | 288 | W |
| Single Avalanche Current Note3 | las | 75 / 88 | Α |
| Single Avalanche Energy Note3 | Eas | 562 / 232 | mJ |
| Channel Temperature | Tch | 175 | °C |
| Storage Temperature | T_{stg} | -55 to +175 | °C |



- **2.** PW \leq 10 μ s, Duty cycle \leq 1 %
- 3. Starting T_{ch} = 25°C, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0 V (See Figure 4.)



(TO-262)



THERMAL RESISTANCE

Channel to Case $R_{th(ch-C)}$ 0.52 °C/W Channel to Ambient °C/W 83.3 Rth(ch-A)

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>
> Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

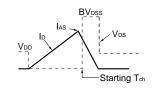


ELECTRICAL CHARACTERISTICS (TA = 25°C)

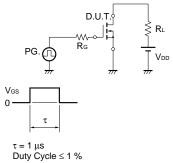
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|---------------------|----------------------------------------------------------------------|------|------|-------|------|
| Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, ID = 44 A | | 4.1 | 5.2 | mΩ |
| | RDS(on)2 | Vgs = 5.0 V, ID = 44 A | | 4.8 | 6.3 | mΩ |
| | RDS(on)3 | Vgs = 4.5 V, ID = 44 A | | 5.1 | 6.8 | mΩ |
| Gate to Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$ | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | y _{fs} | V _{DS} = 10 V, I _D = 44 A | 38 | 75 | | S |
| Drain Leakage Current | IDSS | V _{DS} = 55 V, V _{GS} = 0 V | | | 10 | μΑ |
| Gate to Source Leakage Current | Igss | Vgs = ±20 V, Vps = 0 V | | | ±10 | μΑ |
| Input Capacitance | Ciss | V _{DS} = 25 V V _{GS} = 0 V f = 1 MHz | | 9700 | 14600 | pF |
| Output Capacitance | Coss | | | 1100 | 1700 | pF |
| Reverse Transfer Capacitance | Crss | | | 490 | 890 | pF |
| Turn-on Delay Time | t _{d(on)} | ID = 44 A | | 37 | 82 | ns |
| Rise Time | tr | $V_{GS(on)} = 10 \text{ V}$ $V_{DD} = 28 \text{ V}$ $R_G = 1 \Omega$ | | 22 | 56 | ns |
| Turn-off Delay Time | t _{d(off)} | | | 180 | 360 | ns |
| Fall Time | tf | | | 35 | 88 | ns |
| Total Gate Charge 1 | Q _{G1} | ID = 88 A, VDD = 44 V, VGS = 10 V | | 160 | 240 | nC |
| Total Gate Charge 2 | Q _{G2} | ID = 88 A VDD = 44 V VGS = 5.0 V | | 88 | 140 | nC |
| Gate to Source Charge | Qgs | | | 27 | | nC |
| Gate to Drain Charge | Q _{GD} | | | 48 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | IF = 88 A, VGS = 0 V | | 1.0 | | V |
| Reverse Recovery Time | trr | IF = 88 A, VGS = 0 V | | 62 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/μs | | 120 | | nC |

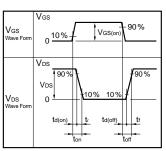
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c|c} D.U.T.S \\ \hline R_G = 25\,\Omega \\ \hline V_{GS} = 20 \rightarrow 0\,V \end{array}$

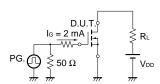


TEST CIRCUIT 2 SWITCHING TIME



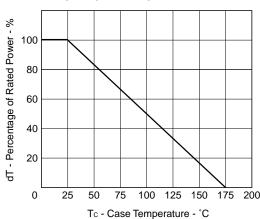


TEST CIRCUIT 3 GATE CHARGE



TYPICAL CHARACTERISTICS (TA = 25°C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



350 ≥ 300 P_T - Total Power Dissipation -250 200 150 100

Figure 2. TOTAL POWER DISSIPATION vs.

CASE TEMPERATURE

100 Tc - Case Temperature - °C

125

150

75

Figure 3. FORWARD BIAS SAFE OPERATING AREA

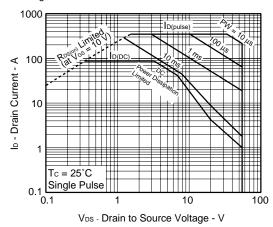
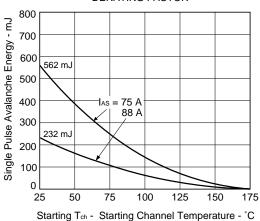


Figure 4. SINGLE AVALANCHE ENERGY **DERATING FACTOR**



50

0

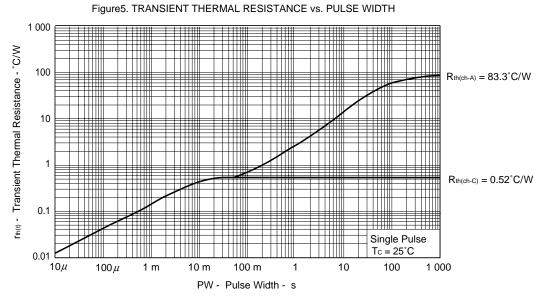


Figure 6. FORWARD TRANSFER CHARACTERISTICS

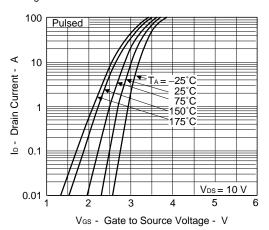


Figure 8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

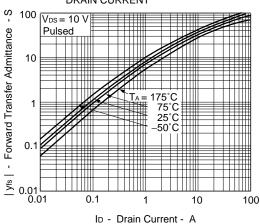


Figure 10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT Pulsed

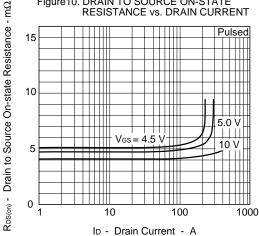


Figure 7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

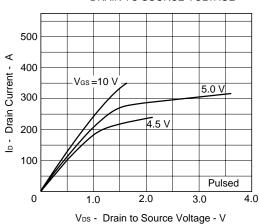


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

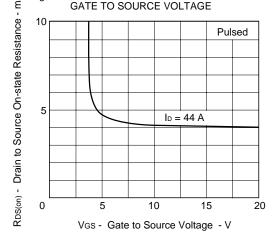
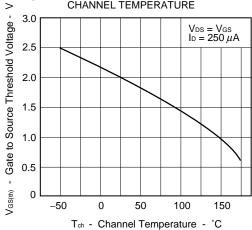
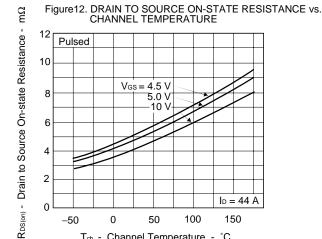


Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE





50

 T_{ch} - Channel Temperature - ${}^{\circ}\mathsf{C}$

100

150

0

-50

Figure 13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE 1000 Pulsed Diode Forward Current - A V_{GS} = 10 V 100 $V_{GS} = 0$ 10 SD

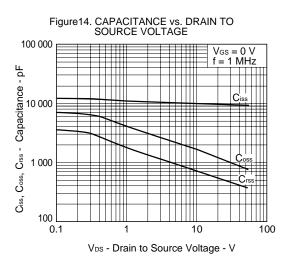
VsD - Source to Drain Voltage - V

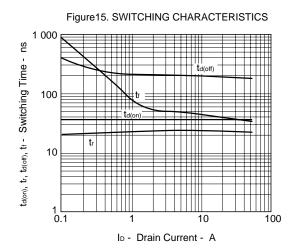
1.0

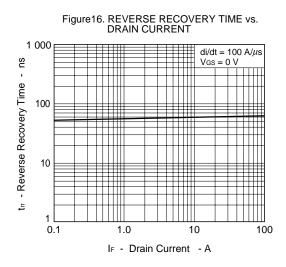
1.5

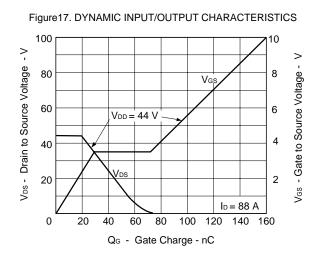
0.5

0.10





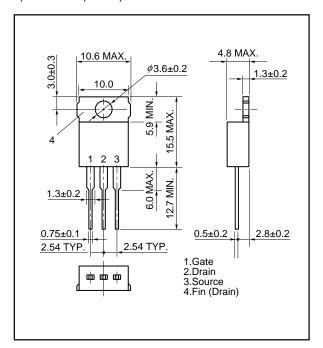




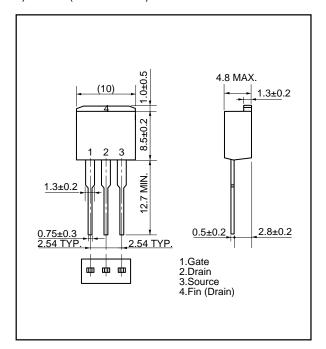
5

PACKAGE DRAWINGS (Unit: mm)

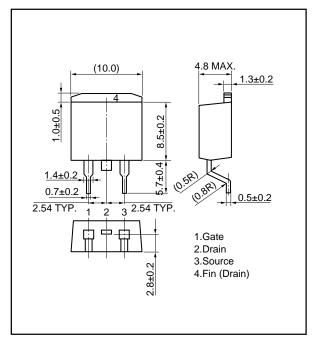
1) TO-220AB (MP-25)



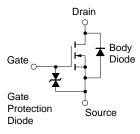
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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